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(12)

United States Design Patent

Adams et al.

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(54) CONTACT FIELD FOR A MOTHERBOARD FOR AN ELECTRONIC TESTING SYSTEM

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(58) Field of Classification Search USPC D13/103, 117, 119, 120, 121, 133, 173, D13/177, 178, 182, 199; D14/230, 301, D14/435.1, 299; D18/26; D24/186, 187 (Continued)

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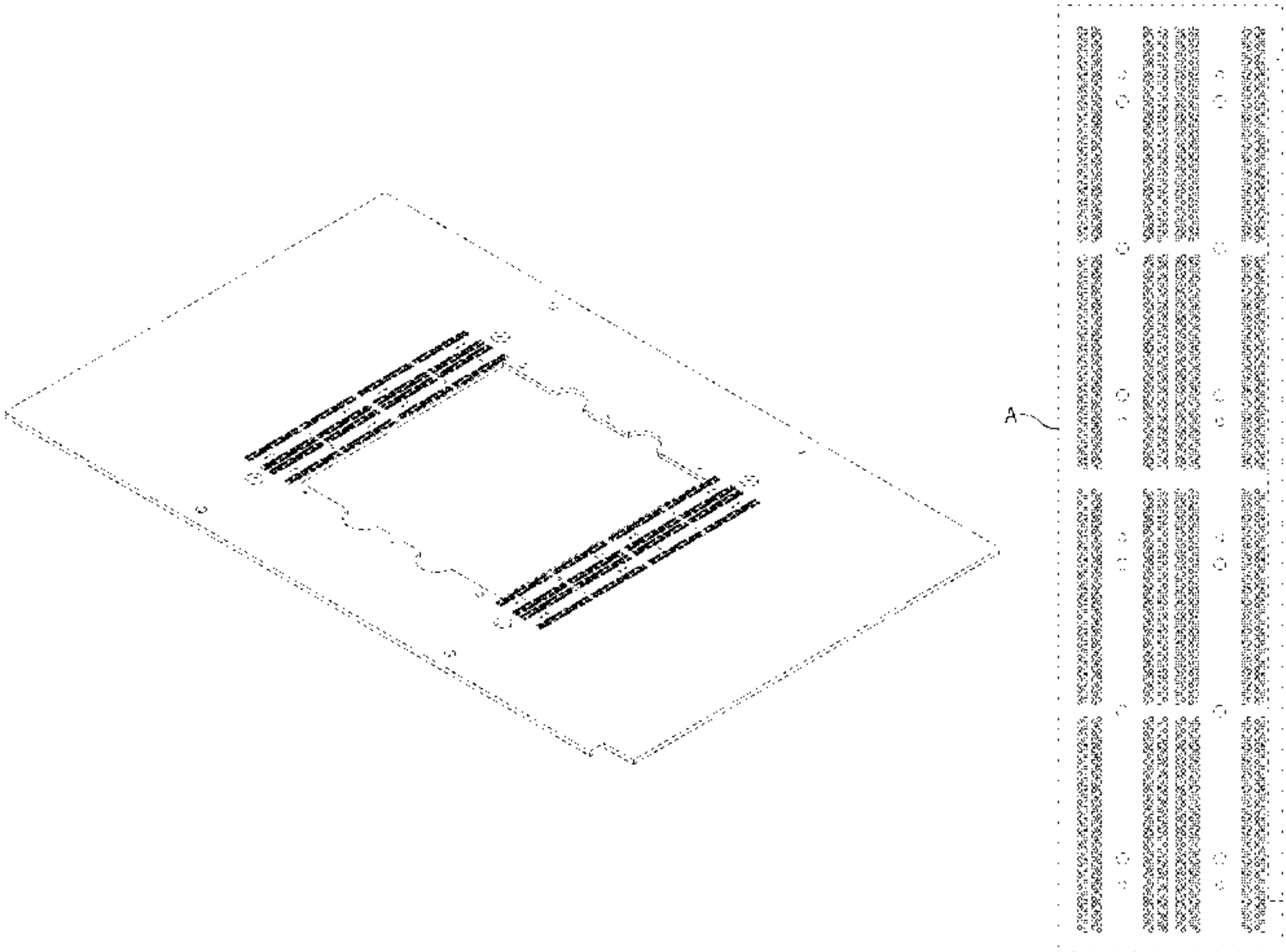
(57) CLAIM

The ornamental design for a contact field for a motherboard for an electronic testing system, as shown and described.

DESCRIPTION

FIG. 1 is a top perspective view of a contact field for a motherboard for an electronic testing system;
FIG. 2 is an alternate top perspective view of a contact field for a motherboard for an electronic testing system;
FIG. 3 is a top plan view of a contact field for a motherboard for an electronic testing system;
FIG. 4 is an enlarged top plan view taken from A in FIG. 3;
FIG. 5 is an enlarged top plan view taken from B in FIG. 3;
FIG. 6 is a bottom plan view of a contact field for a motherboard for an electronic testing system;
FIG. 7 is an enlarged bottom plan view taken from C in FIG. 6;
FIG. 8 is an enlarged bottom plan view taken from D in FIG. 6;
FIG. 9 is a front elevation view of a contact field for a motherboard for an electronic testing system;
FIG. 10 is a rear elevation view of a contact field for a motherboard for an electronic testing system;
FIG. 11 is a left side elevation view of a contact field for a motherboard for an electronic testing system; and,
FIG. 12 is a right side elevation view of a contact field for a motherboard for an electronic testing system.
The dash-dash broken lines depict the environment and portions of the contact field for a motherboard for an electronic testing system that form no part of the claimed design. The dash-dot-dash broken lines depict the boundaries of the enlargements and form no part of the claimed design.

1 Claim, 10 Drawing Sheets



(58) **Field of Classification Search**

CPC H05K 3/30; H05K 3/284; H05K 3/301;
H05K 3/303; H05K 7/02; H05K 7/06;
H05K 7/12; H05K 1/18; H05K 1/181;
H05K 1/182; H05K 1/183; H05K 1/185;
H05K 1/00; H01L 21/00; H01L 21/02;
H01L 23/02; H01L 23/12; H01L 23/16;
H01L 23/58

See application file for complete search history.

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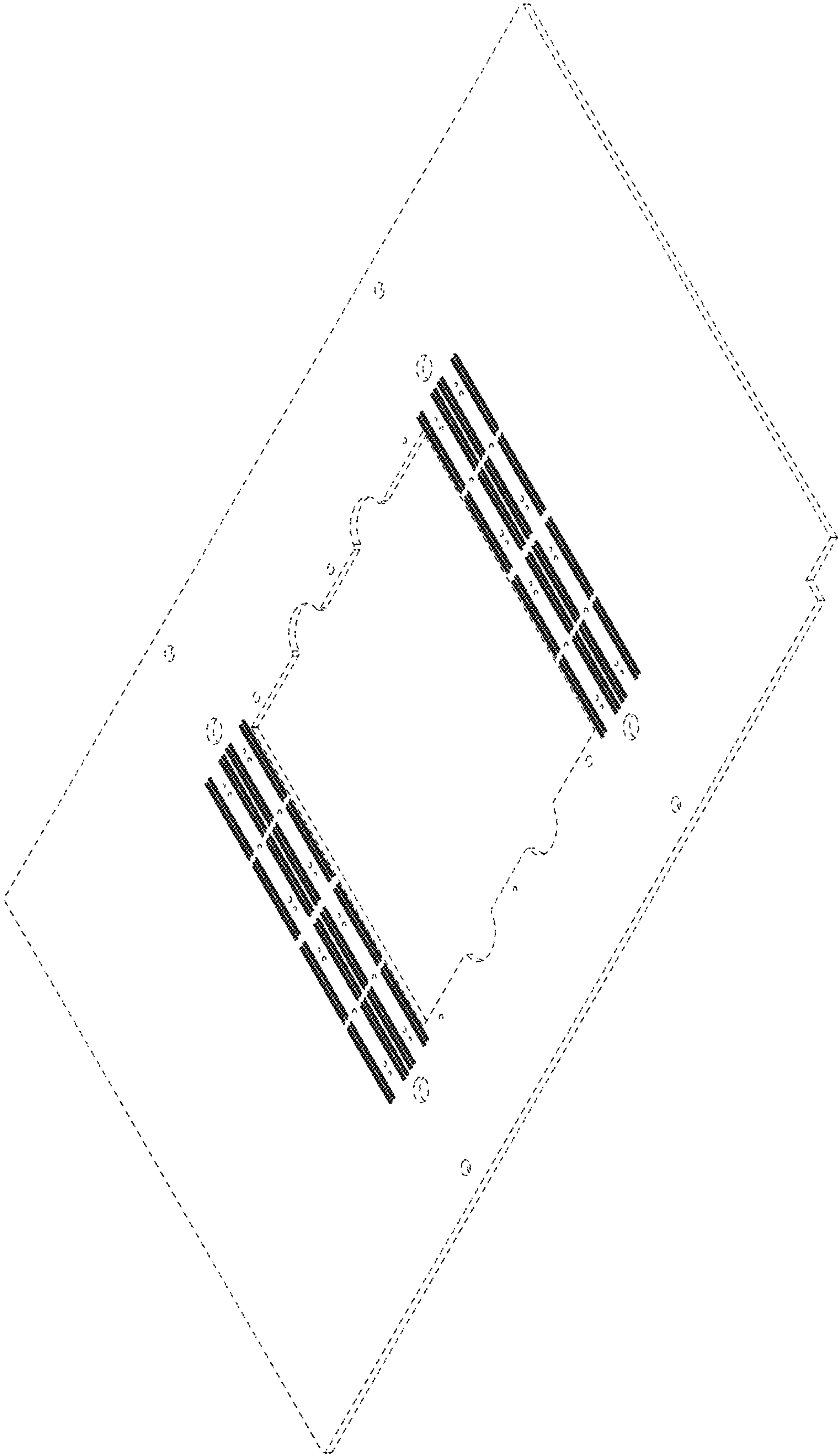


FIG. 1

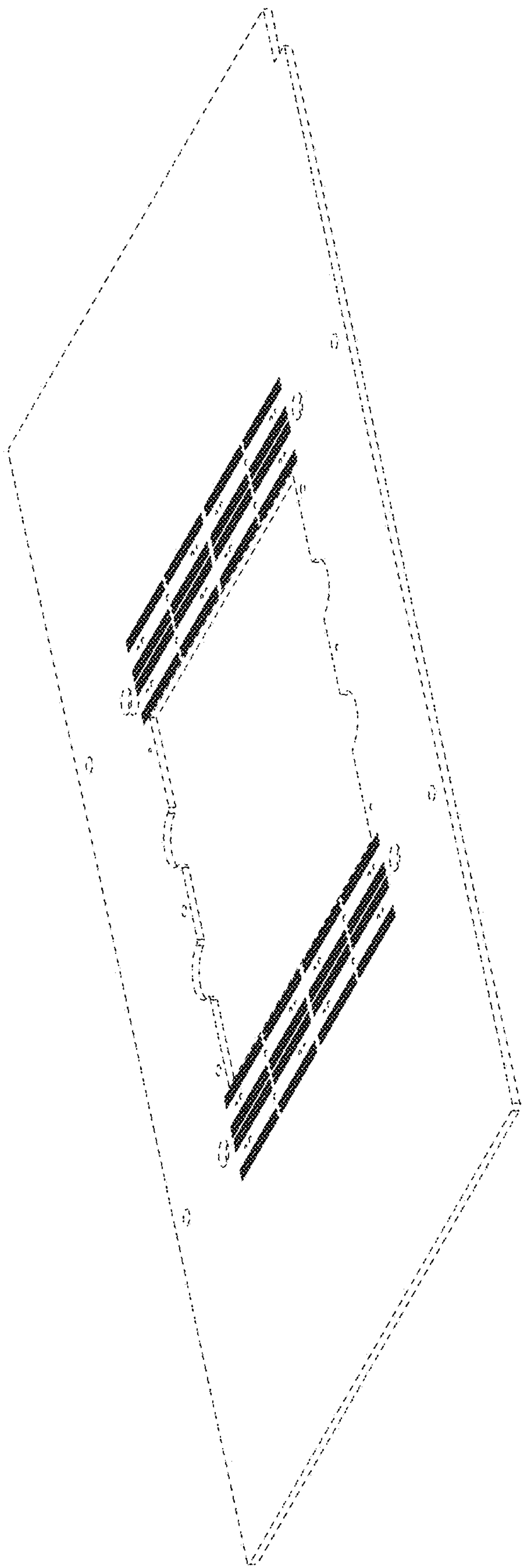


FIG. 2

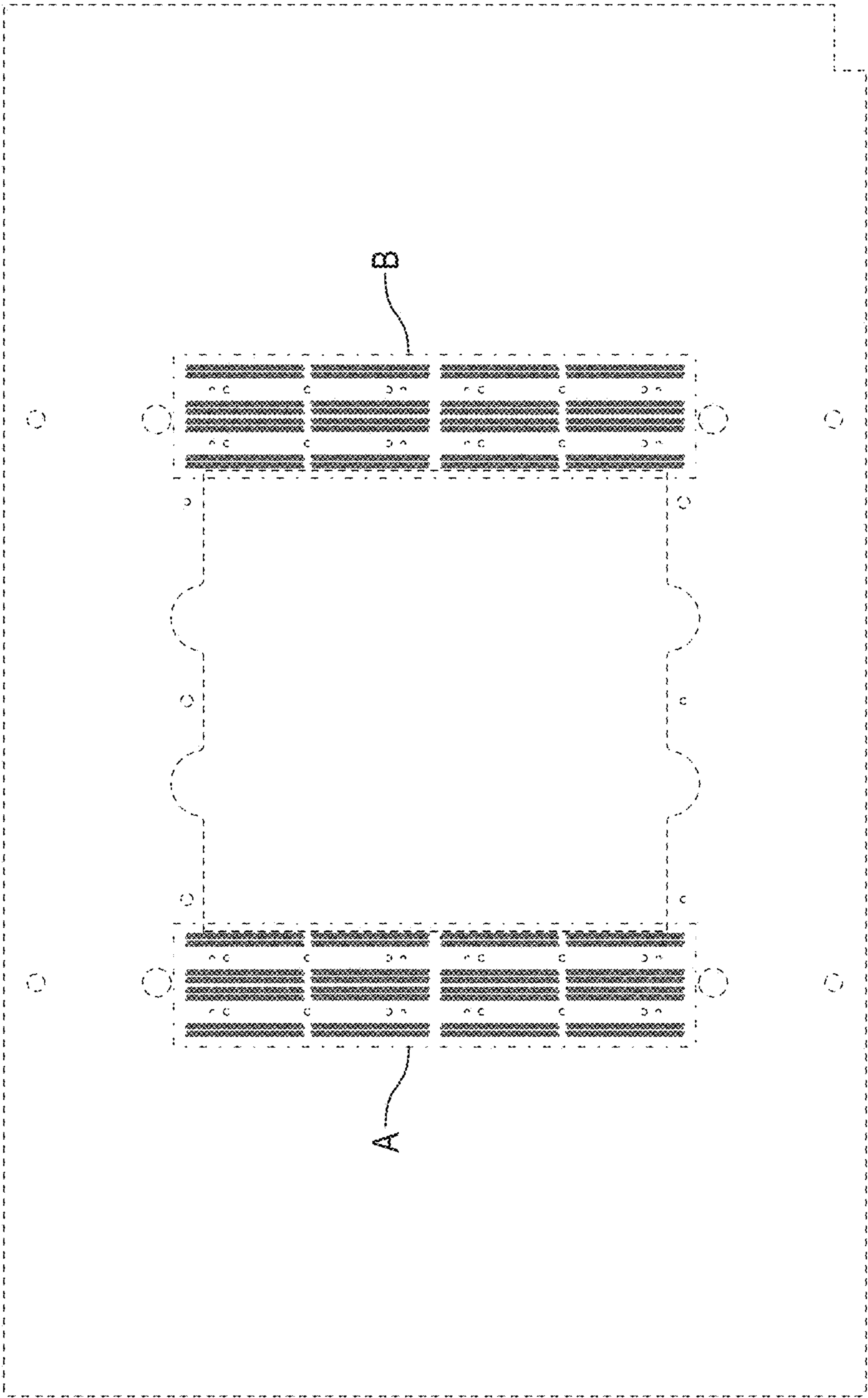


FIG. 3

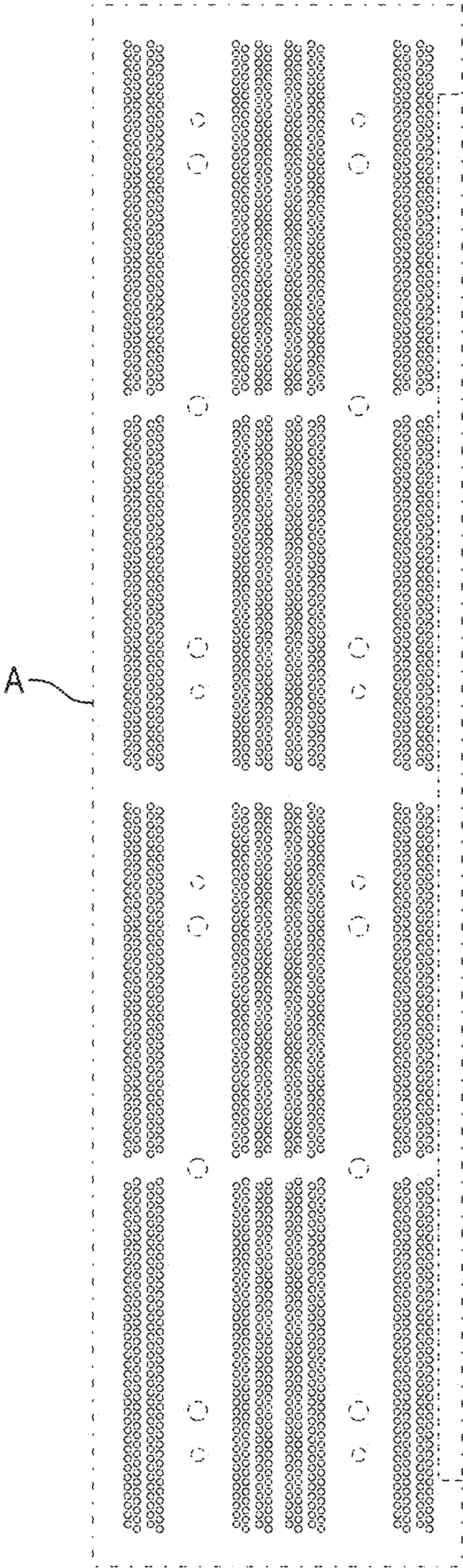


FIG. 4

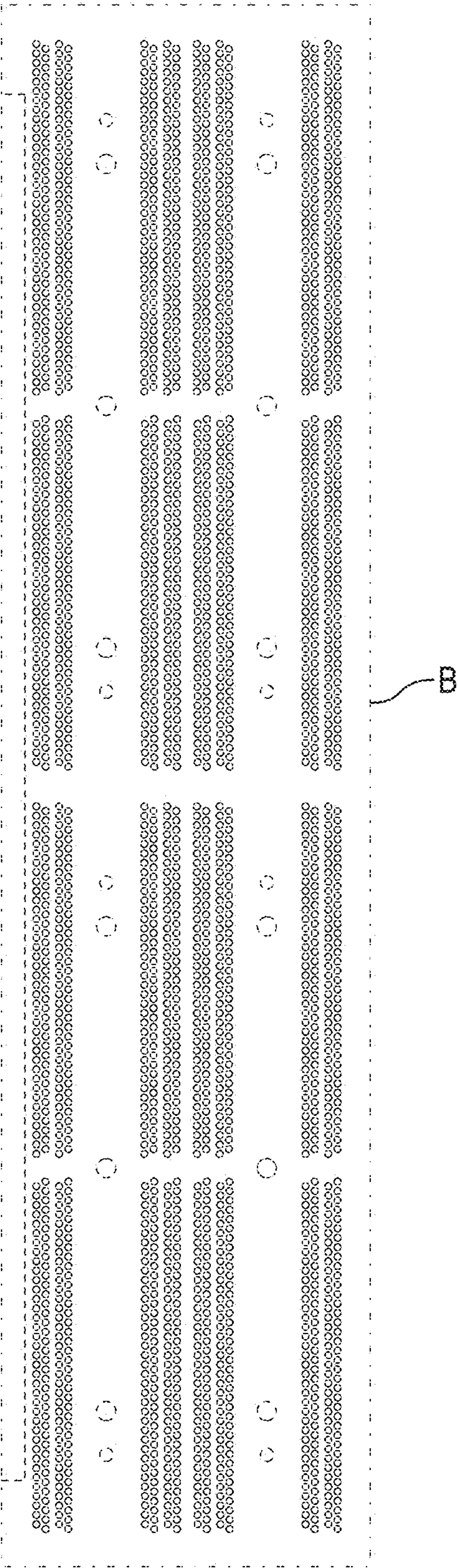


FIG. 5

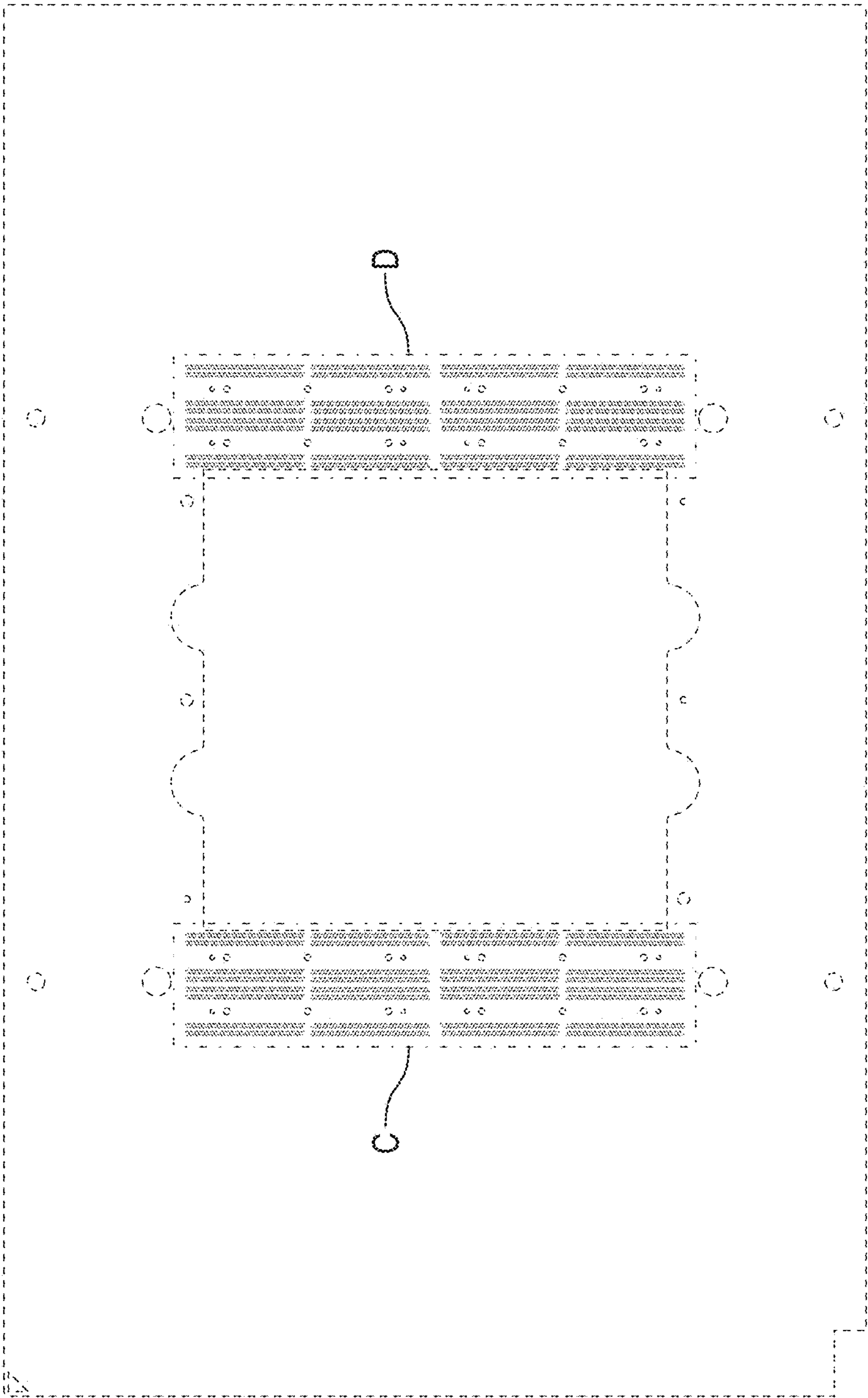


FIG. 6

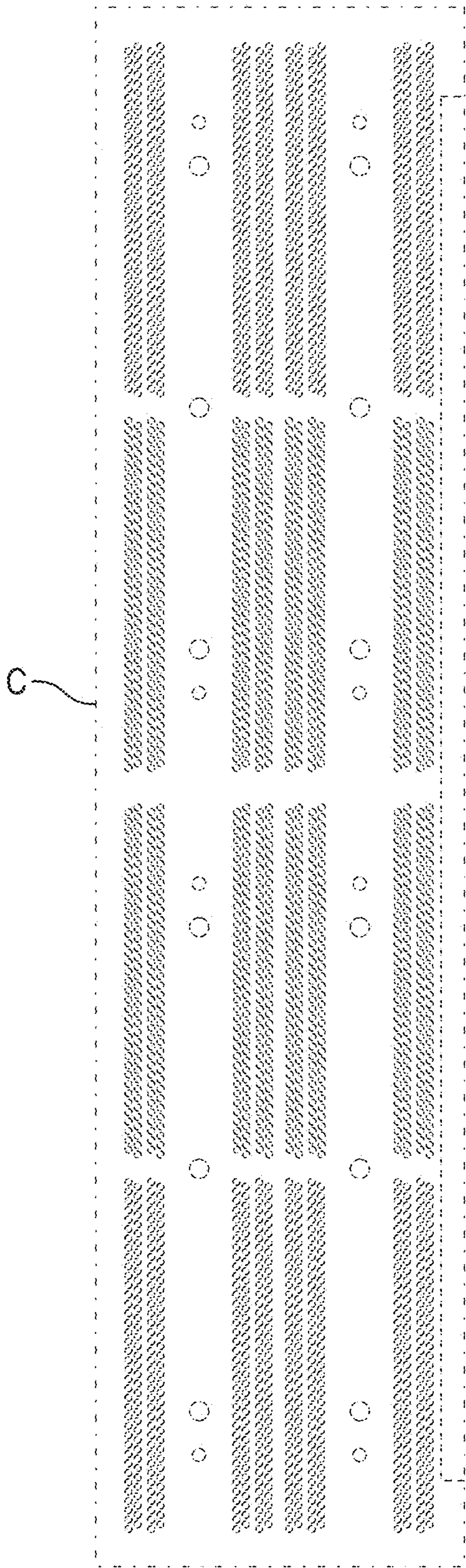


FIG. 7

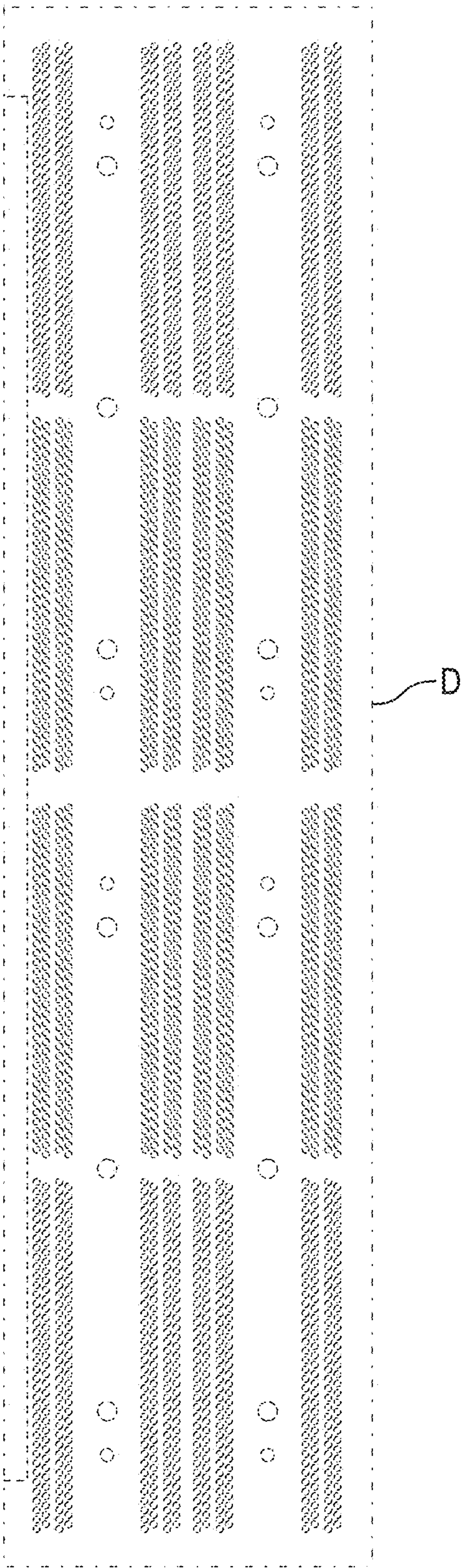


FIG. 8

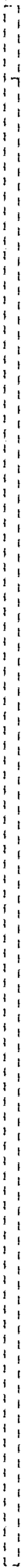


FIG. 9

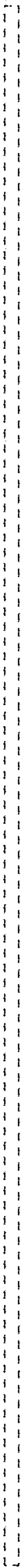


FIG. 10

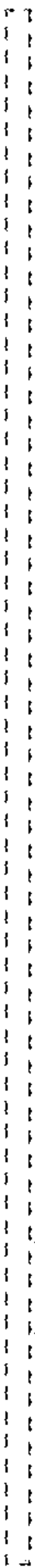


FIG. 11

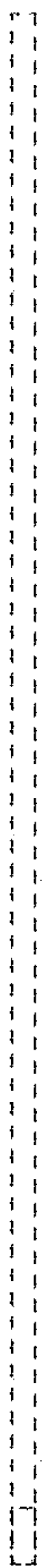


FIG. 12